

## N-channel 650 V, 0.37 $\Omega$ typ., 10 A MDmesh™ M2 Power MOSFET in a TO-220FP ultra narrow leads package

Datasheet - production data

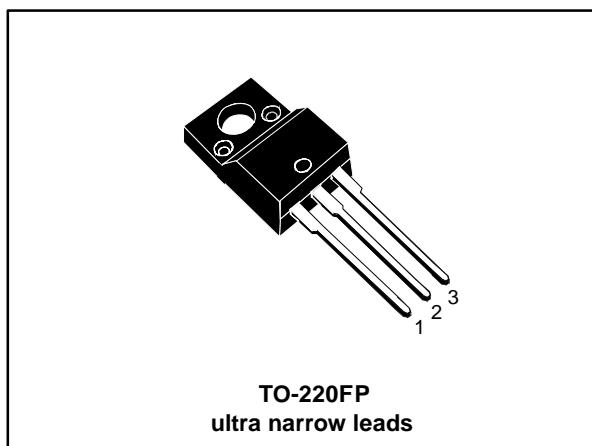
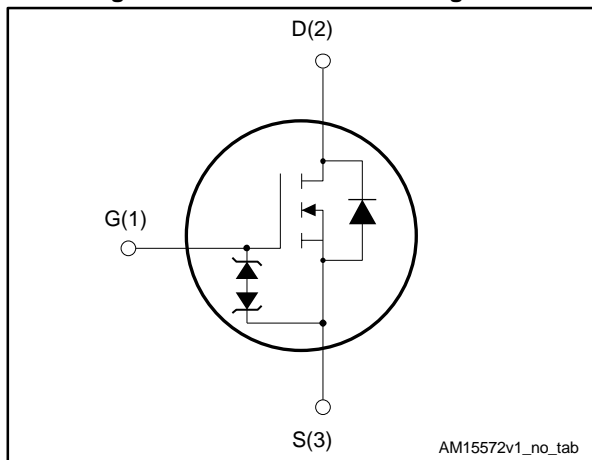


Figure 1: Internal schematic diagram



### Features

| Order code  | V <sub>DS</sub> | R <sub>DS(on)</sub> max | I <sub>D</sub> |
|-------------|-----------------|-------------------------|----------------|
| STFU13N65M2 | 650 V           | 0.43 $\Omega$           | 10A            |

- Extremely low gate charge
- Excellent output capacitance (C<sub>oss</sub>) profile
- 100% avalanche tested
- Zener-protected

### Applications

- Switching applications

### Description

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

Table 1: Device summary

| Order code  | Marking | Package                        | Packaging |
|-------------|---------|--------------------------------|-----------|
| STFU13N65M2 | 13N65M2 | TO-220FP<br>ultra narrow leads | Tube      |

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## Contents

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# 1 Electrical ratings

**Table 2: Absolute maximum ratings**

| Symbol                  | Parameter   | Value              | Unit             |
|-------------------------|---|--------------------|------------------|
| $V_{GS}$                | Gate-source voltage   | $\pm 25$           | V                |
| $I_D$                   | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$  | 10 <sup>(1)</sup>  | A                |
| $I_D$                   | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$   | 6.3 <sup>(1)</sup> | A                |
| $I_{DM}$ <sup>(2)</sup> | Drain current (pulsed)  | 40 <sup>(1)</sup>  | A                |
| $P_{TOT}$               | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$   | 25                 | W                |
| $V_{ISO}$               | Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t = 1\text{ s}$ ; $T_C = 25\text{ }^\circ\text{C}$ ) | 2500               | V                |
| $dv/dt$ <sup>(3)</sup>  | Peak diode recovery voltage slope   | 15                 | V/ns             |
| $dv/dt$ <sup>(4)</sup>  | MOSFET $dv/dt$ ruggedness   | 50                 |                  |
| $T_{stg}$               | Storage temperature   | - 55 to 150        | $^\circ\text{C}$ |
| $T_j$                   | Max. operating junction temperature   | 150                |                  |

**Notes:**

<sup>(1)</sup>Limited by maximum junction temperature..

<sup>(2)</sup>Pulse width limited by safe operating area.

<sup>(3)</sup> $I_{SD} \leq 10\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ;  $V_{DSpeak} < V_{(BR)DSS}$ ,  $V_{DD} = 400\text{ V}$

<sup>(4)</sup> $V_{DS} \leq 520\text{ V}$

**Table 3: Thermal data**

| Symbol         | Parameter                               | Value | Unit                      |
|----------------|---|-------|---------------------------|
| $R_{thj-case}$ | Thermal resistance junction-case max    | 5     | $^\circ\text{C}/\text{W}$ |
| $R_{thj-amb}$  | Thermal resistance junction-ambient max | 62.5  | $^\circ\text{C}/\text{W}$ |

**Table 4: Avalanche characteristics**

| Symbol   | Parameter  | Value | Unit |
|----------|--|-------|------|
| $I_{AR}$ | Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )                                 | 1.8   | A    |
| $E_{AS}$ | Single pulse avalanche energy (starting $T_j = 25\text{ }^\circ\text{C}$ , $I_D = I_{AR}$ ; $V_{DD} = 50\text{ V}$ ) | 350   | mJ   |

## 2 Electrical characteristics

( $T_C = 25\text{ °C}$  unless otherwise specified)

**Table 5: On /off states**

| Symbol        | Parameter  | Test conditions                                    | Min. | Typ. | Max.     | Unit          |
|---------------|--|--|------|------|----------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage                   | $I_D = 1\text{ mA}$ , $V_{GS} = 0\text{ V}$        | 650  |      |          | V             |
| $I_{DSS}$     | Zero gate voltage drain current ( $V_{GS} = 0$ ) | $V_{DS} = 650\text{ V}$                            |      |      | 1        | $\mu\text{A}$ |
|               |  | $V_{DS} = 650\text{ V}$ , $T_C = 125\text{ °C}$    |      |      | 100      | $\mu\text{A}$ |
| $I_{GSS}$     | Gate-body leakage current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 25\text{ V}$                         |      |      | $\pm 10$ | $\mu\text{A}$ |
| $V_{GS(th)}$  | Gate threshold voltage                           | $V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$ | 2    | 3    | 4        | V             |
| $R_{DS(on)}$  | Static drain-source on-resistance                | $V_{GS} = 10\text{ V}$ , $I_D = 5\text{ A}$        |      | 0.37 | 0.43     | $\Omega$      |

**Table 6: Dynamic**

| Symbol                     | Parameter                     | Test conditions   | Min. | Typ.  | Max. | Unit     |
|----------------------------|-------------------------------|---|------|-------|------|----------|
| $C_{ISS}$                  | Input capacitance             | $V_{DS} = 100\text{ V}$ , $f = 1\text{ MHz}$ ,<br>$V_{GS} = 0\text{ V}$   | -    | 590   | -    | pF       |
| $C_{OSS}$                  | Output capacitance            |   | -    | 27.5  | -    | pF       |
| $C_{RSS}$                  | Reverse transfer capacitance  |   | -    | 1.1   | -    | pF       |
| $C_{OSS\text{ eq.}}^{(1)}$ | Equivalent output capacitance | $V_{DS} = 0\text{ to }520\text{ V}$ ,<br>$V_{GS} = 0\text{ V}$            | -    | 168.5 | -    | pF       |
| $R_G$                      | Intrinsic gate resistance     | $f = 1\text{ MHz}$ open drain   | -    | 6.5   | -    | $\Omega$ |
| $Q_g$                      | Total gate charge             | $V_{DD} = 520\text{ V}$ , $I_D = 10\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$ | -    | 17    | -    | nC       |
| $Q_{gs}$                   | Gate-source charge            |   | -    | 3.3   | -    | nC       |
| $Q_{gd}$                   | Gate-drain charge             |   | -    | 7     | -    | nC       |

**Notes:**

<sup>(1)</sup> $C_{OSS\text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{OSS}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 7: Switching times**

| Symbol       | Parameter           | Test conditions  | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 325\text{ V}$ , $I_D = 5\text{ A}$ ,<br>$R_G = 4.7\text{ }\Omega$ , $V_{GS} = 10\text{ V}$ | -    | 11   | -    | ns   |
| $t_r$        | Rise time           |  | -    | 7.8  | -    | ns   |
| $t_{d(off)}$ | Turn-off delay time |  | -    | 38   | -    | ns   |
| $t_f$        | Fall time           |  | -    | 12   | -    | ns   |

Table 8: Source drain diode

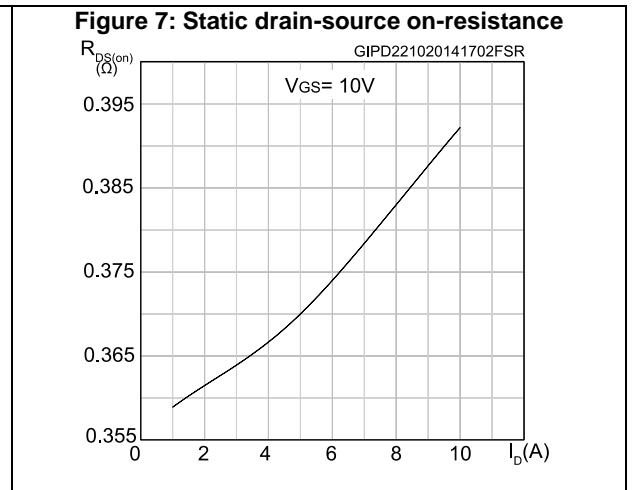
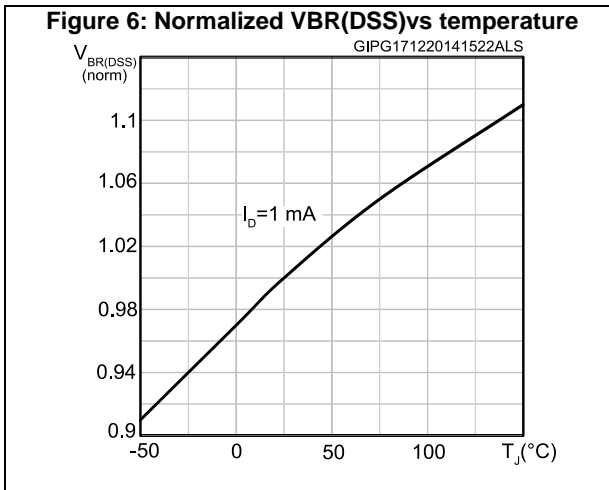
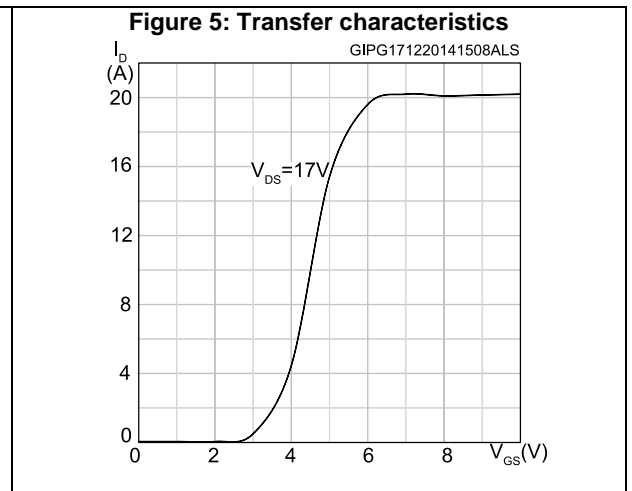
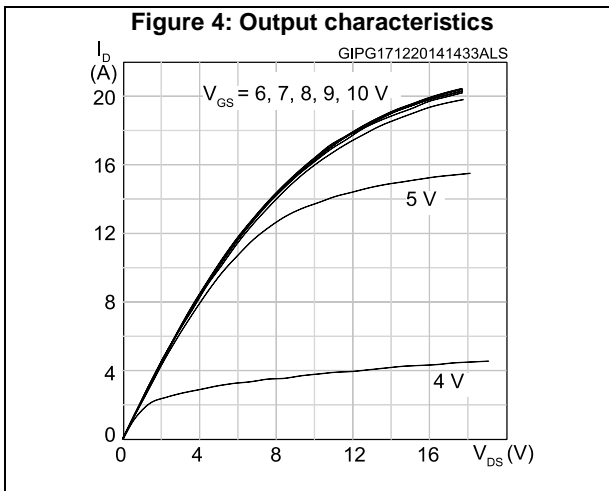
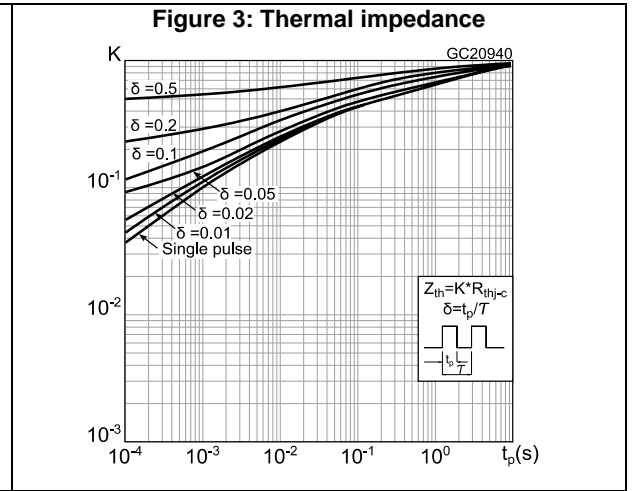
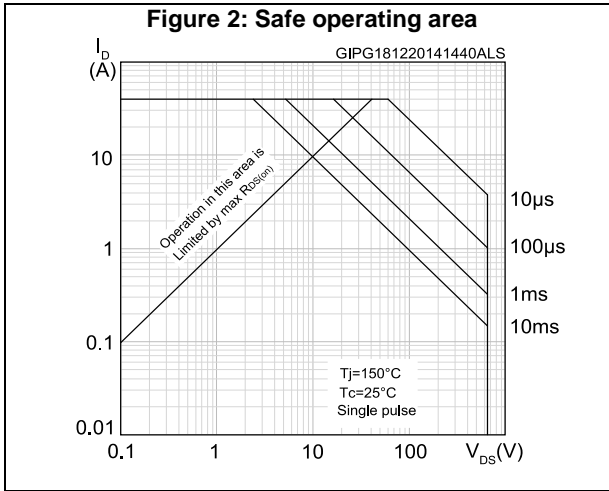
| Symbol          | Parameter                     | Test conditions   | Min. | Typ. | Max. | Unit          |
|-----------------|-------------------------------|---|------|------|------|---------------|
| $I_{SD}$        | Source-drain current          |   | -    |      | 10   | A             |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |   | -    |      | 40   | A             |
| $V_{SD}^{(2)}$  | Forward on voltage            | $I_{SD} = 10 \text{ A}$ , $V_{GS} = 0 \text{ V}$  | -    |      | 1.6  | V             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 10 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 60 \text{ V}$                                      | -    | 312  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 2.7  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 17.5 |      | A             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 10 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 60 \text{ V}$ , $T_j = 150 \text{ }^\circ\text{C}$ | -    | 464  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 4.1  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 17.5 |      | A             |

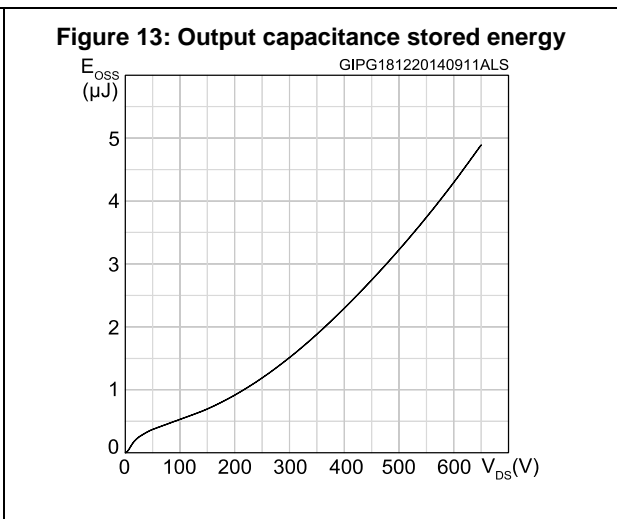
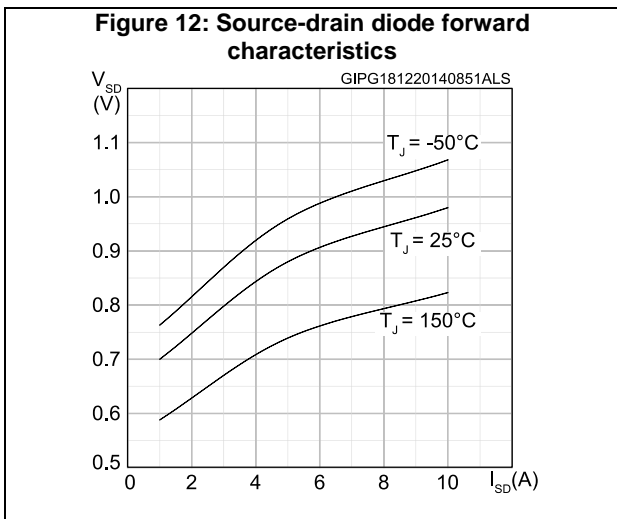
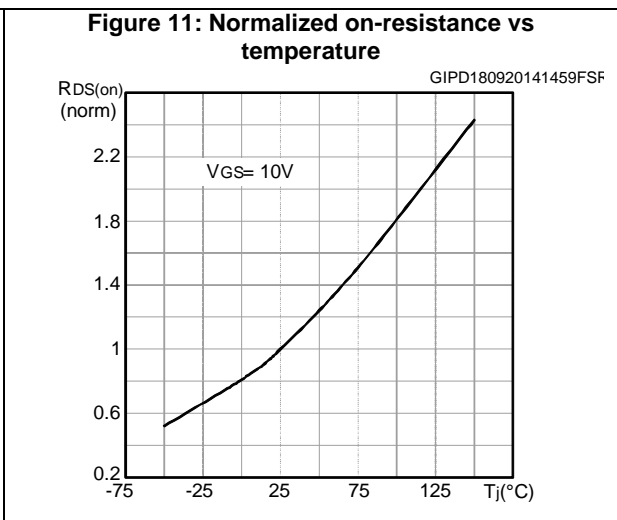
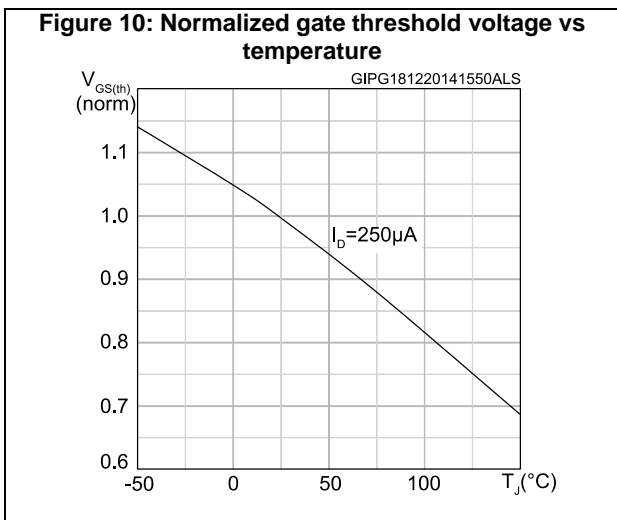
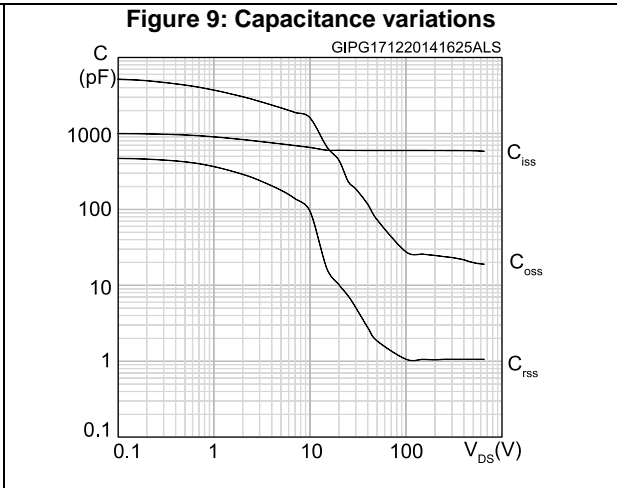
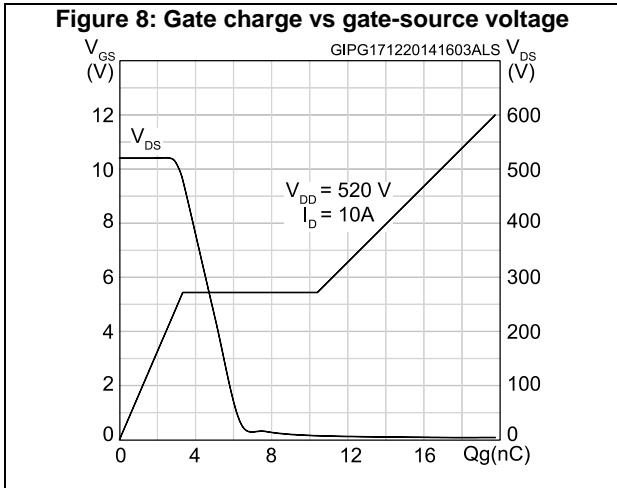
**Notes:**

(1)Pulse width limited by safe operating area.

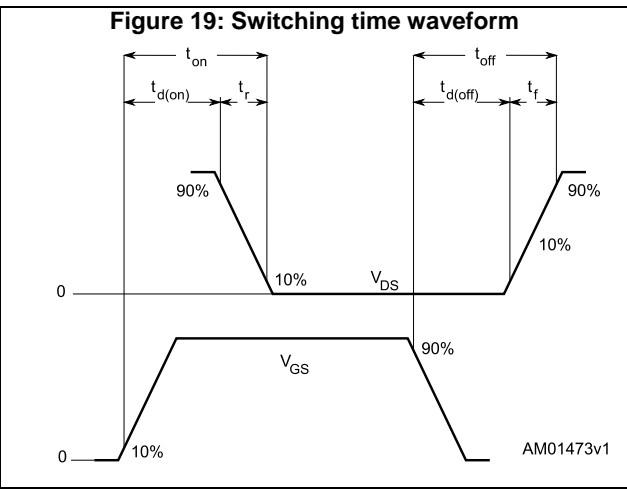
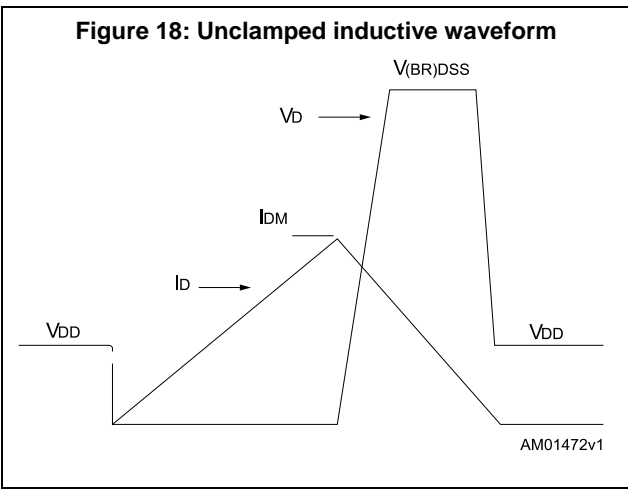
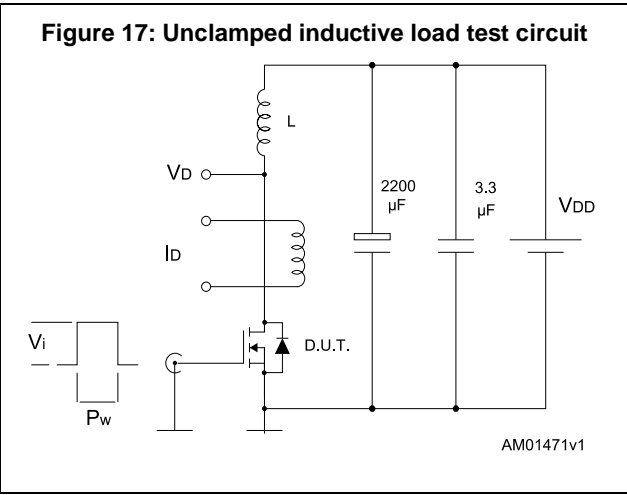
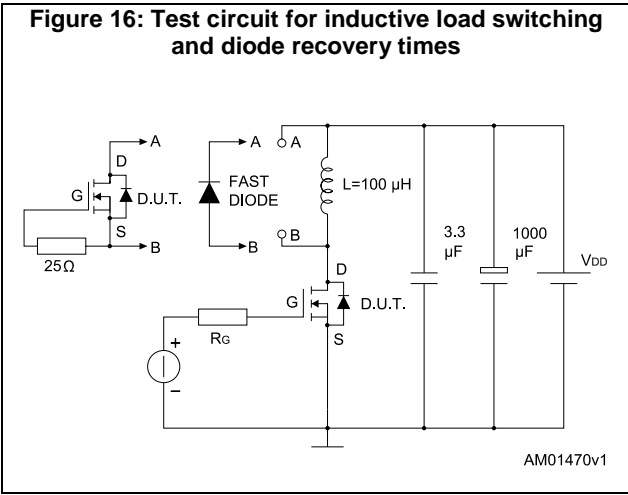
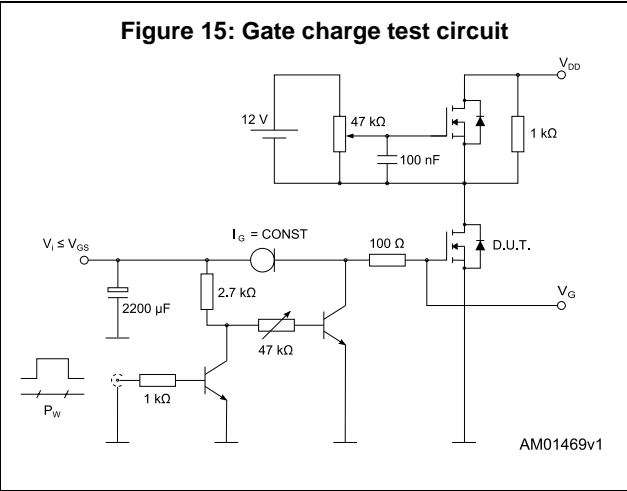
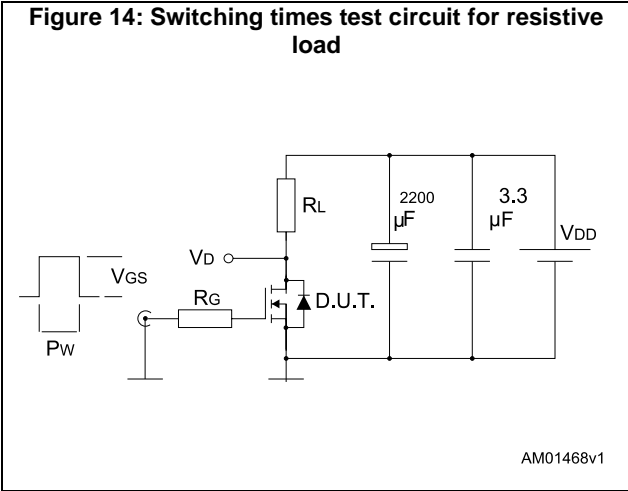
(2)Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

2.1 Electrical characteristics (curves)





### 3 Test circuit





## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 4.1 TO-220FP package information

Figure 20: TO-220FP ultra narrow leads package outline

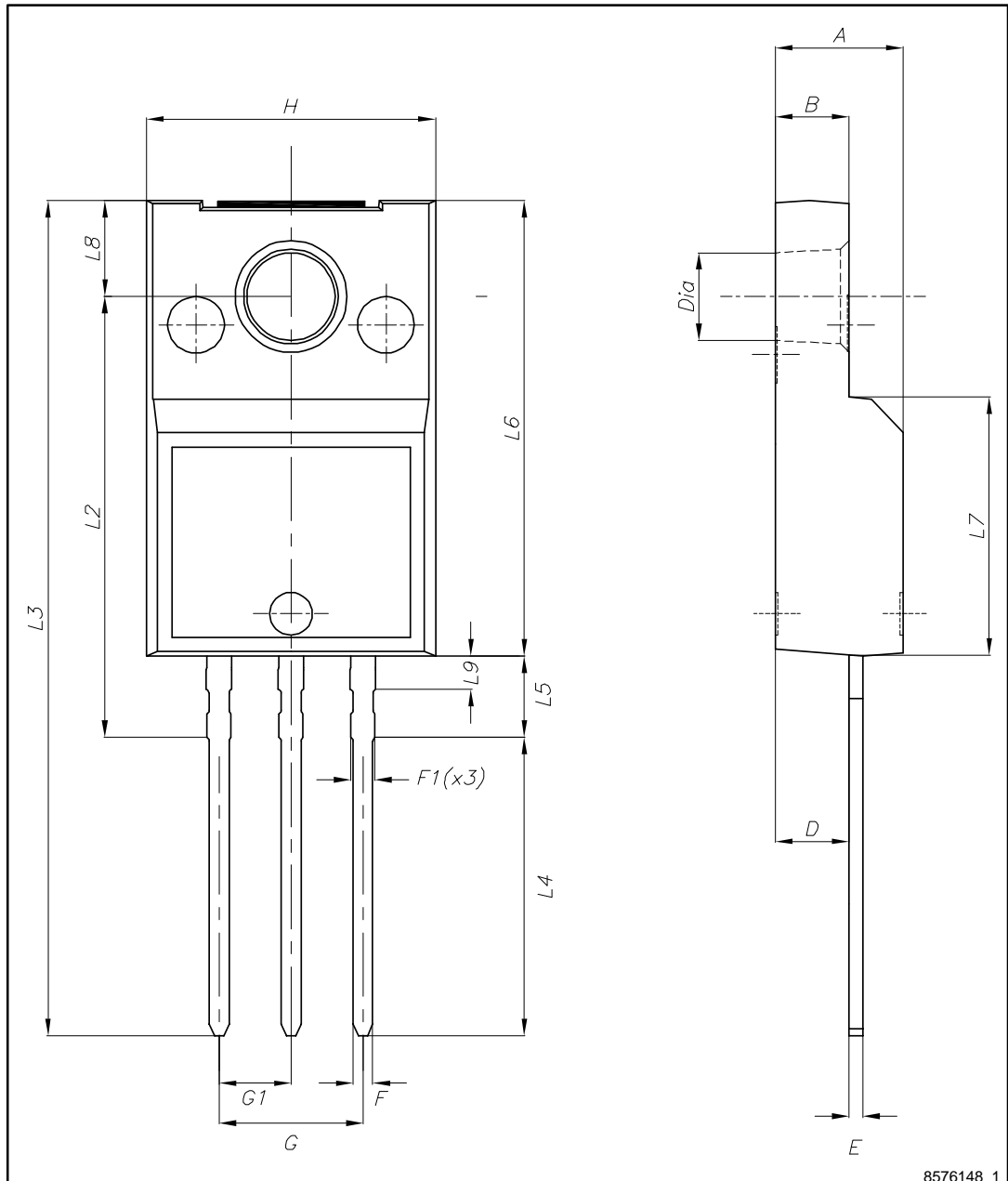


Table 9: TO-220FP ultra narrow leads mechanical data

| Dim. | mm    |      |       |
|------|-------|------|-------|
|      | Min.  | Typ. | Max.  |
| A    | 4.40  |      | 4.60  |
| B    | 2.50  |      | 2.70  |
| D    | 2.50  |      | 2.75  |
| E    | 0.45  |      | 0.60  |
| F    | 0.65  |      | 0.75  |
| F1   | -     |      | 0.90  |
| G    | 4.95  |      | 5.20  |
| G1   | 2.40  | 2.54 | 2.70  |
| H    | 10.00 |      | 10.40 |
| L2   | 15.10 |      | 15.90 |
| L3   | 28.50 |      | 30.50 |
| L4   | 10.20 |      | 11.00 |
| L5   | 2.50  |      | 3.10  |
| L6   | 15.60 |      | 16.40 |
| L7   | 9.00  |      | 9.30  |
| L8   | 3.20  |      | 3.60  |
| L9   | -     |      | 1.30  |
| Dia. | 3.00  |      | 3.20  |

## 5 Revision history

Table 10: Document revision history

| Date        | Revision | Changes         |
|-------------|----------|-----------------|
| 26-May-2015 | 1        | Initial release |

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